Form PTO 1449 U.S. DEPARTMENT OF COMMERCE			ATTY DOCKET NO.		SERIAL NO.		
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LIST OF	REFER	RENCES CITED BY AP	PLICANT	Takeshi OKINO, et al.			
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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	
CICT	AA	6,027,856	02/2000	Nozaki et al.			
JiT	AB	6,013,416	01/2000	Nozlaki et al.			
GCT	AC	4,166,915	09/1979	Bucholz			
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UCT	AE	6,512,067	01/2003	Nishl et al.			
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Form PTO 1449 (Modified)		U.S. DEPARTMENT OF PATENT AND TRADER	COMMERCE MARK OFFICE	ATTY DOCKET NO. 241085US0RDCONT		SERIAL N	NO. 10/635,571	
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400	AP	10-83076	03-31-98	JAPAN w/Attached English Abstract			×	
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4U1	AS	5-127370	05-25-93	JAPAN w/Attached English Abstract			X	
yu -	AT	10-239847	09-11-98	JAPAN w/Attached English Abstract			X	
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40	AA	6,541,597	04-01-03	OKINO et al.			
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